

Chipsmall Limited consists of a professional team with an average of over 10 year of expertise in the distribution of electronic components. Based in Hongkong, we have already established firm and mutual-benefit business relationships with customers from, Europe, America and south Asia, supplying obsolete and hard-to-find components to meet their specific needs.

With the principle of "Quality Parts, Customers Priority, Honest Operation, and Considerate Service", our business mainly focus on the distribution of electronic components. Line cards we deal with include Microchip, ALPS, ROHM, Xilinx, Pulse, ON, Everlight and Freescale. Main products comprise IC, Modules, Potentiometer, IC Socket, Relay, Connector. Our parts cover such applications as commercial, industrial, and automotives areas.

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Power MOSFET

20 V, 4.1 A, Dual N-Channel ChipFET™

Features

- Low R_{DS(on)} and Fast Switching Speed
- Leadless ChipFET Package has 40% Smaller Footprint than TSOP-6
- Excellent Thermal Capabilities Where Heat Transfer is Required
- Pb-Free Package is Available

Applications

- DC-DC Buck/Boost Converters
- Battery and Low Side Switching in Portable Equipment Such as MP3 Players, Cell Phones, DSCs and PDAs
- Level Shifting

MAXIMUM RATINGS (T_J = 25°C unless otherwise noted)

Parameter			Symbol	Value	Unit	
Drain-to-Source Voltage			V_{DSS}	20	V	
Gate-to-Source Voltage			V_{GS}	±12	V	
Continuous Drain	Steady	T _J = 25 °C	I _D	3.0	Α	
Current	State	T _J = 85 °C		2.2		
	t ≤ 5 s	$T_J = 25 ^{\circ}C$		4.1		
Power Dissipation	Steady	T _J = 25 °C	P_{D}	1.13	W	
	State	State	T _J = 85 °C		0.59	
	t ≤ 5 s	T _J = 25 °C		2.1		
Pulsed Drain Current	t _p = 10 μs		I _{DM}	12	Α	
Operating Junction and Storage Temperature			T _J , T _{STG}	–55 to 150	°C	
Lead Temperature for Soldering Purposes (1/8" from case for 10 s)			T _L	260	°C	

THERMAL RESISTANCE RATINGS

Parameter	Symbol	Max	Unit
Junction-to-Ambient - Steady State (Note 1)	$R_{\theta JA}$	110	°C/W

Maximum ratings are those values beyond which device damage can occur. Maximum ratings applied to the device are individual stress limit values (not normal operating conditions) and are not valid simultaneously. If these limits are exceeded, device functional operation is not implied, damage may occur and reliability may be affected.

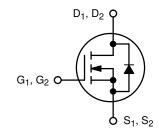
 Surface Mounted on FR4 Board using 1 in sq pad size (Cu area = 1.27 in sq [1 oz] including traces).



ON Semiconductor®

http://onsemi.com

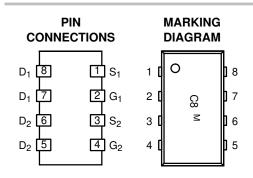
V _{(BR)DSS}	R _{DS(on)} TYP	I _D MAX
20 V	60 mΩ @ 4.5 V	4.1 A
20 v	80 mΩ @ 2.5 V	



N-Channel MOSFET



ChipFET CASE 1206A STYLE 2



C8 = Specific Device Code M = Month Code

ORDERING INFORMATION

Device	Package	Shipping [†]
NTHD4508NT1	ChipFET	3000/Tape & Reel
NTHD4508NT1G	ChipFET (Pb-Free)	3000/Tape & Reel

†For information on tape and reel specifications, including part orientation and tape sizes, please refer to our Tape and Reel Packaging Specification Brochure, BRD8011/D.

ELECTRICAL CHARACTERISTICS ($T_J = 25^{\circ}C$ unless otherwise noted)

Parameter	Symbol	Test Conditions	Min	Тур	Max	Units
OFF CHARACTERISTICS	•		•	-		•
Drain-to-Source Breakdown Voltage	V _{(BR)DSS}	V _{GS} = 0 V	20			V
Zero Gate Voltage Drain Current	I _{DSS}	V _{GS} = 0 V, V _{DS} = 16 V			1.0	μΑ
		V _{GS} = 0 V, V _{DS} = 16 V, T _J = 125°C			10	1
Gate-to-Source Leakage Current	I _{GSS}	$V_{DS} = 0 \text{ V}, V_{GS} = \pm 12 \text{ V}$			±100	nA
ON CHARACTERISTICS (Note 2)						
Gate Threshold Voltage	V _{GS(TH)}	$V_{GS} = V_{DS}, I_D = 250 \mu A$	0.6		1.2	V
Drain-to-Source On-Resistance	R _{DS(on)}	V _{GS} = 4.5, I _D = 3.1 A		60	75	mΩ
		V _{GS} = 2.5, I _D = 2.3 A		80	115	1
Forward Transconductance	9 _{FS}	$V_{DS} = 10 \text{ V}, I_D = 3.1 \text{ A}$		6.0		S
CHARGES AND CAPACITANCES						
Input Capacitance	C _{ISS}			180		pF
Output Capacitance	Coss	$V_{GS} = 0 \text{ V, f} = 1.0 \text{ MHz,}$ $V_{DS} = 10 \text{ V}$		80		1
Reverse Transfer Capacitance	C _{RSS}	- VDS - 10 1		25		1
Total Gate Charge	Q _{G(TOT)}			2.6	4.0	nC
Threshold Gate Charge	Q _{G(TH)}	$V_{GS} = 4.5 \text{ V}, V_{DS} = 10 \text{ V},$		0.5		1
Gate-to-Source Charge	Q _{GS}	$V_{GS} = 4.5 \text{ V}, V_{DS} = 10 \text{ V},$ $I_{D} = 3.1 \text{ A}$		0.6		1
Gate-to-Drain Charge	Q_{GD}			0.7		1
SWITCHING CHARACTERISTICS (Note	9 3)					
Turn-On Delay Time	t _{d(ON)}			5.0	10	ns
Rise Time	t _r	V _{GS} = 4.5 V, V _{DS} = 16 V,		15	30	1
Turn-Off Delay Time	t _{d(OFF)}	$I_D = 3.1 \text{ A}, R_G = 2.5 \Omega$		10	20	1
Fall Time	t _f			3.0	6.0	1
DRAIN-SOURCE DIODE CHARACTER	ISTICS					
Forward Diode Voltage	V _{SD}	$V_{GS} = 0 \text{ V}, I_S = 3.1 \text{ A}$		0.75	1.15	V
Reverse Recovery Time	t _{RR}			12.5		ns
Charge Time	ta	$V_{GS} = 0 \text{ V, } I_{S} = 1.5 \text{ A,}$		9.0		1
Discharge Time	tb	dl _S /dt = 100 A/μs		3.5		1
Reverse Recovery Charge	Q _{RR}	1		6.0		nC

Pulse Test: Pulse Width ≤ 300 μs, Duty Cycle ≤ 2%.
 Switching characteristics are independent of operating junction temperatures.

TYPICAL PERFORMANCE CURVES (T_J = 25°C unless otherwise noted)

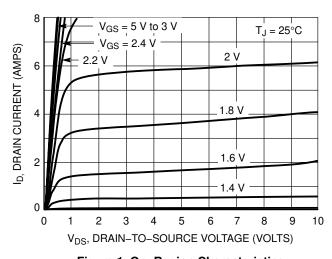


Figure 1. On-Region Characteristics

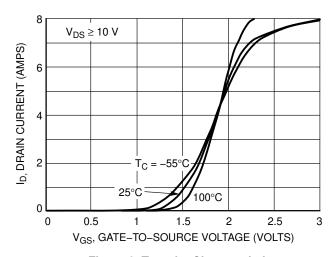


Figure 2. Transfer Characteristics

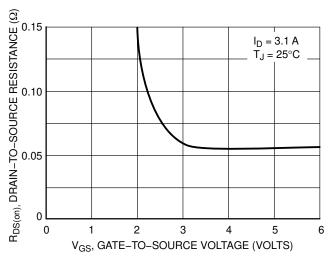


Figure 3. On-Resistance vs. Gate-to-Source Voltage

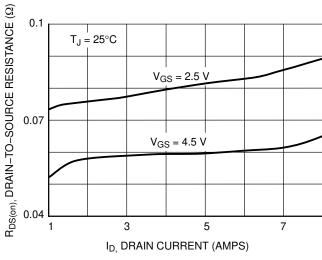


Figure 4. On–Resistance vs. Drain Current and Gate Voltage

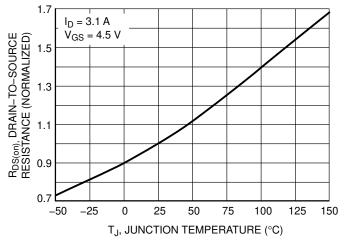


Figure 5. On–Resistance Variation with Temperature

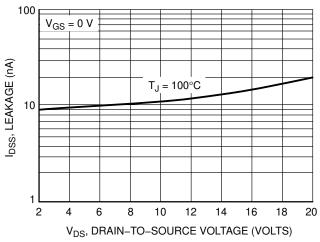
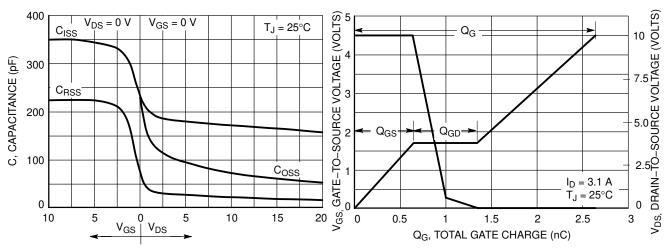


Figure 6. Drain-to-Source Leakage Current vs. Voltage

TYPICAL PERFORMANCE CURVES (T_J = 25°C unless otherwise noted)



GATE-TO-SOURCE OR DRAIN-TO-SOURCE VOLTAGE (VOLTS)

Figure 7. Capacitance Variation

Figure 8. Gate-to-Source and Drain-to-Source Voltage vs. Total Charge

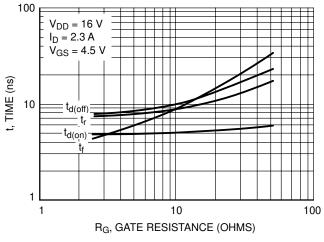


Figure 9. Resistive Switching Time Variation vs. Gate Resistance

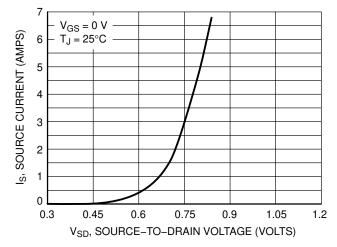


Figure 10. Diode Forward Voltage vs. Current

SOLDERING FOOTPRINTS*

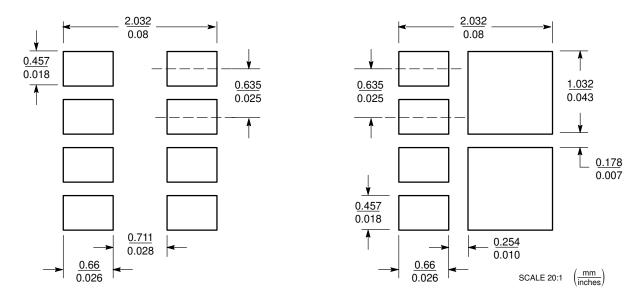


Figure 11. Basic

Figure 12. Style 2

BASIC PAD PATTERNS

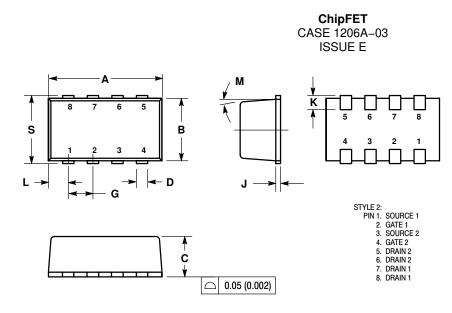
The basic pad layout with dimensions is shown in Figure 11. This is sufficient for low power dissipation MOSFET applications, but power semiconductor performance requires a greater copper pad area, particularly for the drain leads.

The minimum recommended pad pattern shown in Figure 12 improves the thermal area of the drain connections (pins 5, 6, 7, 8) while remaining within the confines of the basic

footprint. The drain copper area is 0.0019 sq. in. (or 1.22 sq. mm). This will assist the power dissipation path away from the device (through the copper lead–frame) and into the board and exterior chassis (if applicable) for the single device. The addition of a further copper area and/or the addition of vias to other board layers will enhance the performance still further.

^{*}For additional information on our Pb–Free strategy and soldering details, please download the ON Semiconductor Soldering and Mounting Techniques Reference Manual, SOLDERRM/D.

PACKAGE DIMENSIONS



NOTES:

- DIMENSIONING AND TOLERANCING PER ANSI Y14.5M, 1982.
- 2. CONTROLLING DIMENSION: MILLIMETER.
- MOLD GATE BURRS SHALL NOT EXCEED 0.13 MM PER SIDE.
 LEADFRAME TO MOLDED BODY OFFSET IN
- LEADFRAME TO MOLDED BODY OFFSET IN
 HORIZONTAL AND VERTICAL SHALL NOT EXCEED
 0.08 MM.
- 5. DIMENSIONS A AND B EXCLUSIVE OF MOLD GATE BURRS
- 6. NO MOLD FLASH ALLOWED ON THE TOP AND
- BOTTOM LEAD SURFACE.
 7. 1206A-01 AND 1206A-02 OBSOLETE. NEW STANDARD IS 1206A-03.

	MILLIMETERS		INCHES		
DIM	MIN	MAX	MIN	MAX	
Α	2.95	3.10	0.116	0.122	
В	1.55	1.70	0.061	0.067	
С	1.00	1.10	0.039	0.043	
D	0.25	0.35	0.010	0.014	
G	0.65 BSC		0.025 BSC		
J	0.10	0.20	0.004	0.008	
K	0.28	0.42	0.011	0.017	
L	0.55 BSC		0.022 BSC		
M	5° NOM		5° NOM		
S	1.80	2.00	0.072	0.080	

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